

FDZ7296

30V N-Channel PowerTrench^ò BGA MOSFET

General Description

Combining Fairchild's advanced PowerTrench process with state-of-the-art BGA packaging, the FDZ7296 minimizes both PCB space and $R_{\rm DS(ON)}.$ This BGA MOSFET embodies a breakthrough in packaging technology which enables the device to combine excellent thermal transfer characteristics, high current handling capability, ultra-low profile packaging, low gate charge, and low $R_{\rm DS(ON)}.$

Applications

 High-side Mosfet in DC-DC converters for Server and Notebook applications

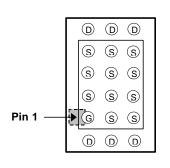
Features

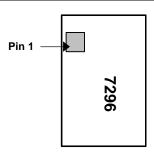
11 A, 30 V. $R_{DS(ON)} = 8$.

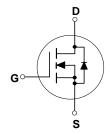
 $R_{DS(ON)} = 8.5 \text{ m}\Omega$ @ $V_{GS} = 10 \text{ V}$

 $R_{\text{DS(ON)}}$ = 12 $m\Omega$ @ V_{GS} = 4.5 V

- Occupies only 0.10 cm² of PCB area: 1/3 the area of SO-8.
- Ultra-thin package: less than 0.80 mm height when mounted to PCB.
- High performance trench technology for extremely low R_{DS(ON)}
- Optimized for low Qg and Qgd to enable fast switching and reduce CdV/dt gate coupling







Top

Absolute Maximum Ratings TA=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		30	V
V _{GSS}	Gate-Source Voltage		±20	V
I _D	Drain Current - Continuous	(Note 1a)	11	А
	Pulsed		20	
P _D	Power Dissipation (Steady State)	(Note 1a)	2.1	W
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

R _{θJA}	Thermal Resistance, Junction-to-Ambient	(Note 1a)	60	°C/W
$R_{\theta JB}$	Thermal Resistance, Junction-to-Ball	(Note 1)	6.3	
R _{θJC}	Thermal Resistance, Junction-to-Case	(Note 1)	0.6	

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
7296	FDZ7296	7"	8mm	3000 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{D} = 250 \mu\text{A}$	30			V
$\Delta BV_{DSS} \over \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C		27		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, \qquad V_{GS} = 0 \text{ V}$			1	μΑ
I _{GSS}	Gate-Body Leakage.	$V_{GS} = \pm 20 \text{ V}, \qquad V_{DS} = 0 \text{ V}$			±100	nA
On Chara	acteristics (Note 2)					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	1	1.8	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C		-4.9		mV/°C
$R_{\text{DS(on)}}$	Static Drain–Source On–Resistance	$V_{GS} = 10 \text{ V}, \qquad I_D = 11 \text{ A}$ $V_{GS} = 4.5 \text{ V}, \qquad I_D = 10 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 11 \text{ A}, T_J = 125 ^{\circ}\text{C}$		7 9 9.1	8.5 12 13	mΩ
Dynamic Characteristics						
C _{iss}	Input Capacitance	$V_{DS} = 15 \text{ V}, \qquad V_{GS} = 0 \text{ V},$		1520		pF
C _{oss}	Output Capacitance	f = 1.0 MHz		420		pF
C _{rss}	Reverse Transfer Capacitance]		130		pF
G FS	Forward Transconductance	$V_{DS} = 5 \text{ V}, \qquad I_{D} = 11 \text{ A}$		46		S
R _G	Gate Resistance	V _{GS} = 15 mV, f = 1.0 MHz		1.1		Ω
Switchin	g Characteristics (Note 2)					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 15 \text{ V}, \qquad I_{D} = 1 \text{ A},$		10	20	ns
t _r	Turn-On Rise Time	$V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 6 \Omega$		4	8	ns
t _{d(off)}	Turn-Off Delay Time			27	43	ns
t _f	Turn-Off Fall Time]		13	23	ns
Q _{g(TOT)}	Total Gate Charge at Vgs=10V			22	31	nC
Qg	Total Gate Charge at Vgs=5V	$V_{DD} = 15 \text{ V}, I_{D} = 11 \text{ A},$		12	17	nC
Q _{gs}	Gate-Source Charge	1		4.5		nC
Q _{gd}	Gate-Drain Charge			3.1		nC
Drain-Sc	ource Diode Characteristics	and Maximum Ratings				
Is	Maximum Continuous Drain-Source	<u>~</u>			1.7	Α
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 1.7 \text{ A}$ (Note 2)		0.7	1.2	V
t _{rr}	Diode Reverse Recovery Time	I _F = 11A		28		nS
Q _{rr}	Diode Reverse Recovery Charge	$d_{iF}/d_t = 100 \text{ A/}\mu\text{s}$ (Note 2)		18		nC

R_{0,JA} is determined with the device mounted on a 1 in² 2 oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. The thermal resistance from the junction to the circuit board side of the solder ball, R_{0,JB}, is defined for reference. For R_{0,JC}, the thermal reference point for the case is defined as the top surface of the copper chip carrier. R_{0,JC} and R_{0,JB} are guaranteed by design while R_{0,JA} is determined by the user's board design.



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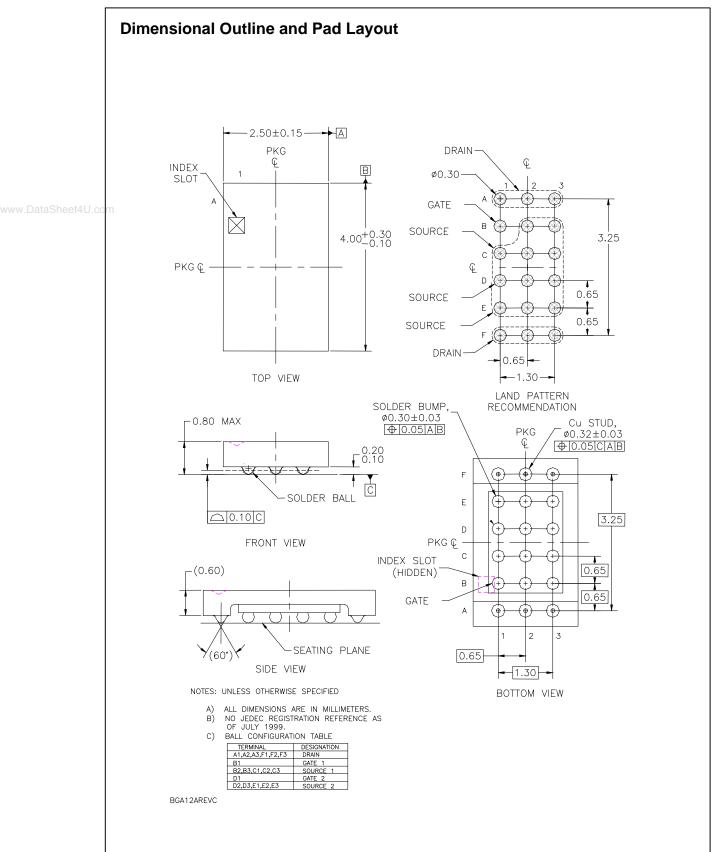
a) 60°C/W when mounted on a 1in² pad of 2 oz copper, 1.5" x 1.5" x 0.062" thick PCB



b) 108°C/W when mounted on a minimum pad of 2 oz copper

Scale 1 : 1 on letter size paper

^{2.} Pulse Test: Pulse Width < 300μ s, Duty Cycle < 2.0%



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Typical Characteristics

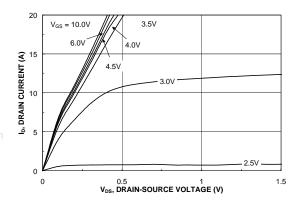


Figure 1. On-Region Characteristics.

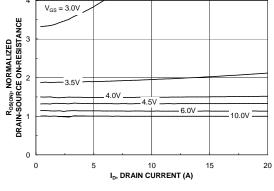


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

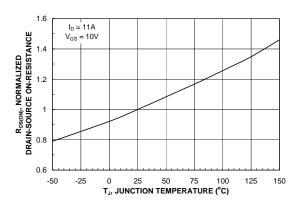


Figure 3. On-Resistance Variation with Temperature.

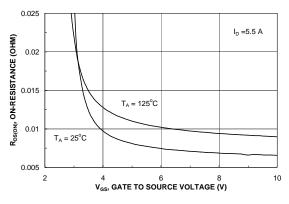


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

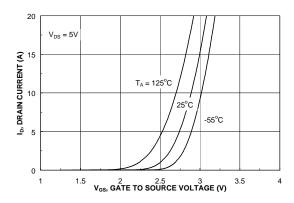


Figure 5. Transfer Characteristics.

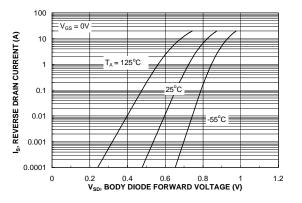
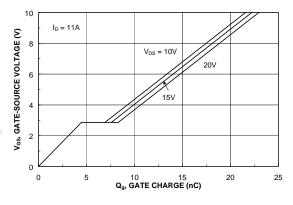


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

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Typical Characteristics



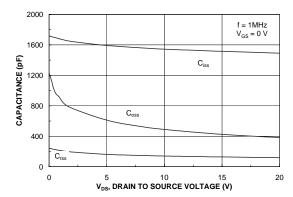
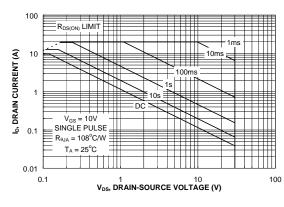


Figure 7. Gate Charge Characteristics.





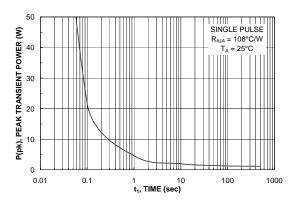


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

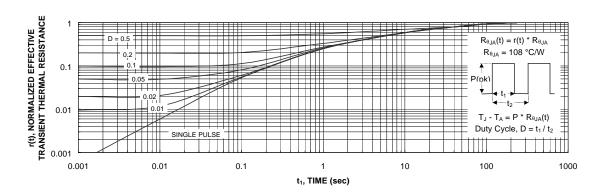


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

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